

L Number	Hits	Search Text	DB	Time stamp
1	467	(257/530).CCLS.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2003/04/19 15:19

L Number	Hits	Search Text	DB	Time stamp
1	577	(257/529) .CCLS.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2003/04/19 15:21

L Number	Hits	Search Text	DB	Time stamp
1	1512	semiconductor and antifuse	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/04/19 15:24
2	484	(semiconductor and antifuse) and edge	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/04/19 15:25
3	382	((semiconductor and antifuse) and edge) and (intersection or cross)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/04/19 15:29
4	41	((semiconductor and antifuse) and edge) and (intersection or cross) and perimeter	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/04/19 15:26
5	371	((semiconductor and antifuse) and edge) and current	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/04/19 15:30